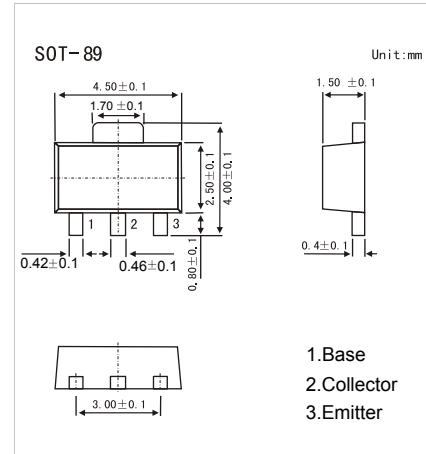


PNP Transistors

2SA1766

■ Features

- Adoption of FBET, MBIT processes.
- High DC current gain ($hFE=500$ to 1200).
- Large current capacity.
- Low collector-to-emitter saturation voltage.
- High V_{EBO} .



■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Collector - Base Voltage	V_{CBO}	-30	V
Collector - Emitter Voltage	V_{CEO}	-25	
Emitter - Base Voltage	V_{EBO}	-15	
Collector Current - Continuous	I_C	-300	mA
Collector Current - Pulse	I_{CP}	-500	
Base Current	I_B	-60	
Collector Power Dissipation (Note.1)	P_C	1.3	W
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature range	T_{stg}	-55 to 150	

Note.1: Mounted on ceramic board (250mm² X 0.8mm)

■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-base breakdown voltage	V_{CBO}	$I_C = -100 \mu\text{A}, I_E = 0$	-30			V
Collector-emitter breakdown voltage	V_{CEO}	$I_C = -1 \text{ mA}, R_{BE} = \infty$	-25			
Emitter-base breakdown voltage	V_{EBO}	$I_E = -100 \mu\text{A}, I_C = 0$	-15			
Collector-base cut-off current	I_{CBO}	$V_{CB} = -20 \text{ V}, I_E = 0$			-0.1	μA
Emitter cut-off current	I_{EBO}	$V_{EB} = -10 \text{ V}, I_C = 0$			-0.1	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = -200 \text{ mA}, I_B = -4 \text{ mA}$		-0.12	-0.5	V
Base-emitter saturation voltage	$V_{BE(sat)}$	$I_C = -200 \text{ mA}, I_B = -4 \text{ mA}$		-0.77	-1.1	
DC current gain	$h_{FE}(1)$	$V_{CE} = -5 \text{ V}, I_C = -10 \text{ mA}$	500	800	1200	
	$h_{FE}(2)$	$V_{CE} = -5 \text{ V}, I_C = -200 \text{ mA}$	200			
Collector output capacitance	C_{ob}	$V_{CB} = -10 \text{ V}, f = 1 \text{ MHz}$		12		pF
Transition frequency	f_T	$V_{CE} = -10 \text{ V}, I_C = -10 \text{ mA}$		100		MHz

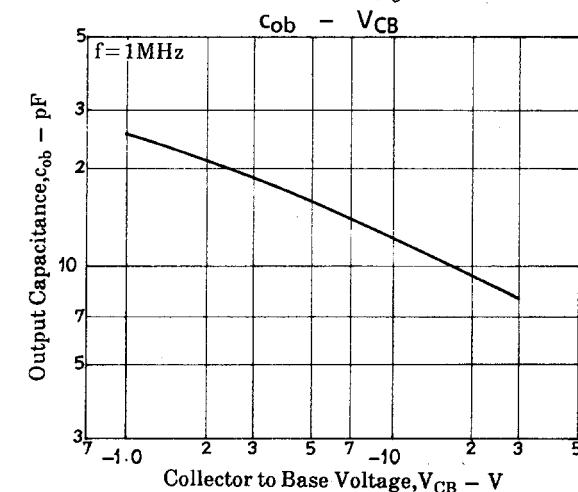
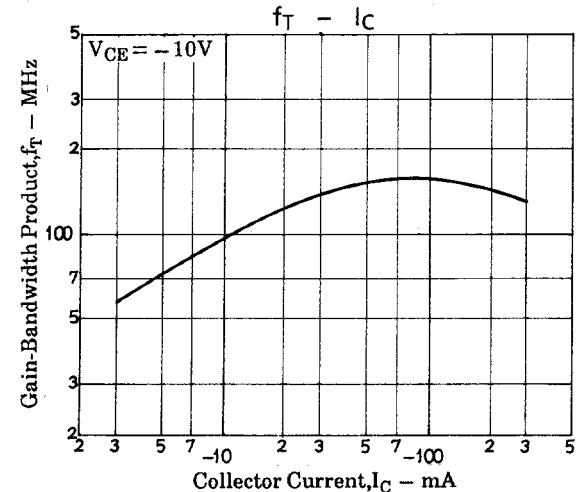
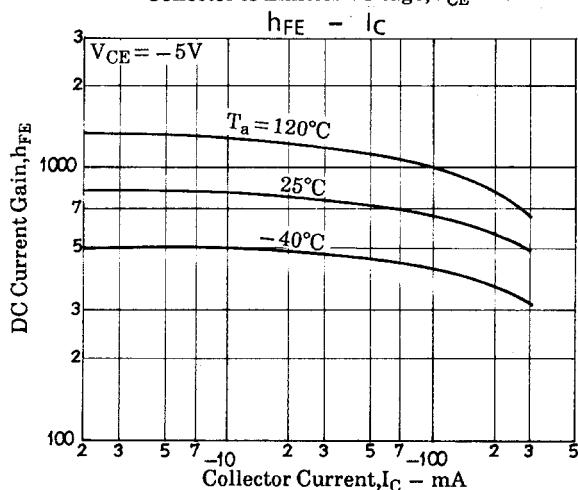
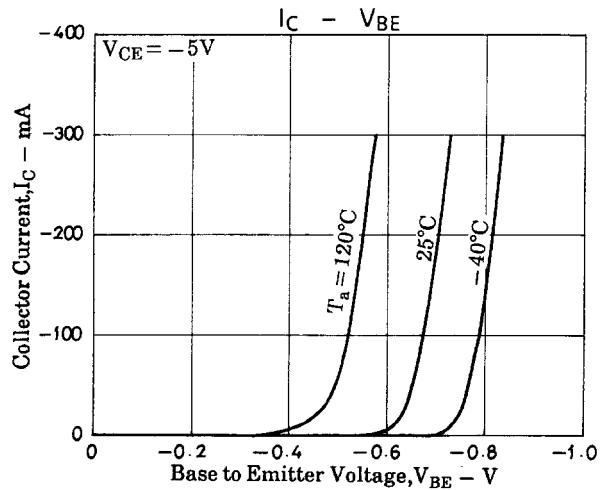
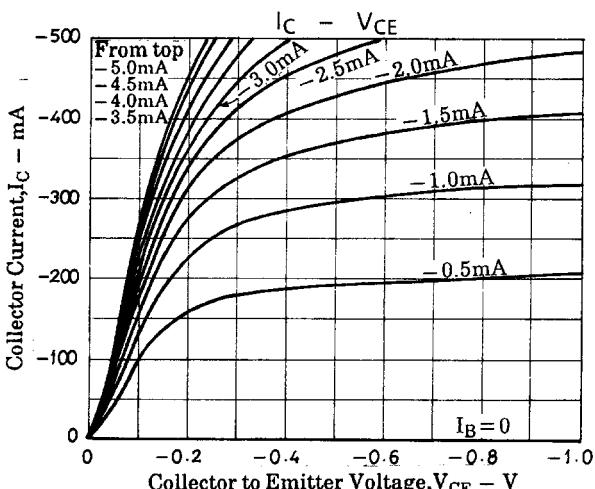
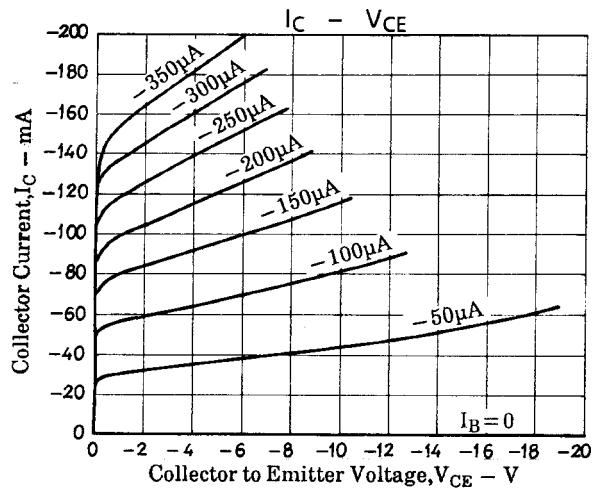
■ Marking

Marking	AL
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PNP Transistors

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■ Typical Characteristics



PNP Transistors

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■ Typical Characteristics

